

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ABERNATHY ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2002/0116181	08-2002	Khan et al.	704/205
	C	US-			
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